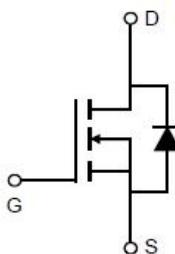


## QIAOXIN N-Channel Super Trench Power MOSFET

### Description

The VCRRP40T11AK uses **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of  $R_{DS(ON)}$  and  $Q_g$ . This device is ideal for high-frequency switching and synchronous rectification.



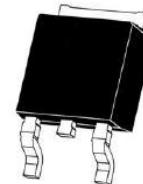
Schematic Diagram

### General Features

- $V_{DS} = 40V, I_D = 110A$
- $R_{DS(ON)} = 3.2m\Omega$  (typical) @  $V_{GS} = 10V$
- Excellent gate charge  $\times R_{DS(on)}$  product(FOM)
- Very low on-resistance  $R_{DS(on)}$
- 175 °C operating temperature
- Pb-free lead plating
- 100% UIS tested

### Application

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification



TO-252 -2L top view

### Package Marking and Ordering Information

Device Marking	Device	Device Package
VCRRP40T11AK		TO-252-2L

### Absolute Maximum Ratings ( $T_c=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	$V_{DS}$	40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current-Continuous	$I_D$	110	A
Drain Current-Continuous( $T_c=100^\circ C$ )	$I_D (100^\circ C)$	85	A
Pulsed Drain Current	$I_{DM}$	440	A
Maximum Power Dissipation	$P_D$	150	W
Derating factor		1	W/ $^\circ C$
Single pulse avalanche energy (Note 1)	$E_{AS}$	480	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 To 175	$^\circ C$

## Thermal Characteristic

Thermal Resistance,Junction-to-Case	$R_{\theta JC}$	1	°C/W
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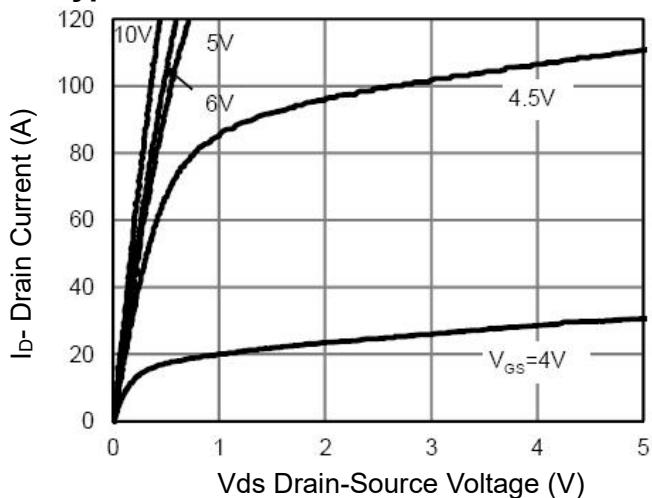
## Electrical Characteristics ( $T_c=25^\circ C$ unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS}=0V, I_D=250\mu A$	40		-	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=40V, V_{GS}=0V$	-	-	1	$\mu A$
Gate-Body Leakage Current	$I_{GSS}$	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2	2.8	4	V
Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=55A$	-	3.2	4.2	$m\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS}=5V, I_D=55A$		60	-	S
<b>Dynamic Characteristics</b>						
Input Capacitance	$C_{iss}$	$V_{DS}=20V, V_{GS}=0V, F=1.0MHz$	-	2750	-	PF
Output Capacitance	$C_{oss}$		-	850	-	PF
Reverse Transfer Capacitance	$C_{rss}$		-	54	-	PF
<b>Switching Characteristics</b> (Note 2)						
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=20V, I_D=55A, V_{GS}=10V, R_G=1.6\Omega$	-	9	-	nS
Turn-on Rise Time	$t_r$		-	3.5	-	nS
Turn-Off Delay Time	$t_{d(off)}$		-	31	-	nS
Turn-Off Fall Time	$t_f$		-	4	-	nS
Total Gate Charge	$Q_g$	$V_{DS}=20V, I_D=55A, V_{GS}=10V$	-	38.5		nC
Gate-Source Charge	$Q_{gs}$		-	13.5		nC
Gate-Drain Charge	$Q_{gd}$		-	7.0		nC
<b>Drain-Source Diode Characteristics</b>						
Diode Forward Voltage	$V_{SD}$	$V_{GS}=0V, I_S=55A$	-		1.2	V
Diode Forward Current	$I_S$		-	-	110	A
Reverse Recovery Time	$t_{rr}$	$T_J = 25^\circ C, I_F = I_S$ $di/dt = 100A/\mu s$	-	22	-	nS
Reverse Recovery Charge	$Q_{rr}$		-	62	-	nC

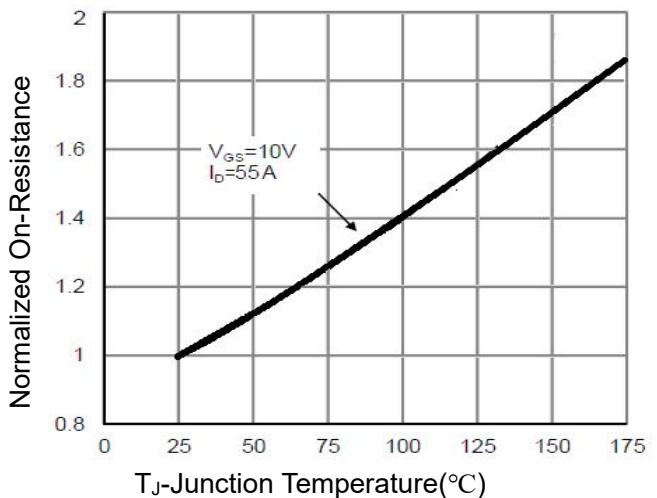
## Notes:

- EAS condition :  $T_j=25^\circ C, V_{DD}=20V, V_G=10V, L=0.5mH, R_g=25\Omega$
- Guaranteed by design, not subject to production
- These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink  $k$ , assuming a maximum junction temperature of  $T_J(MAX)=175^\circ C$ . The SOA curve provides a single pulse rating.

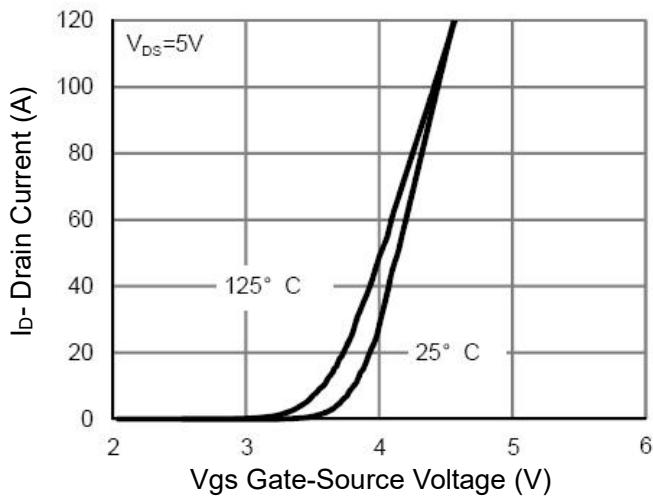
### Typical Electrical and Thermal Characteristics



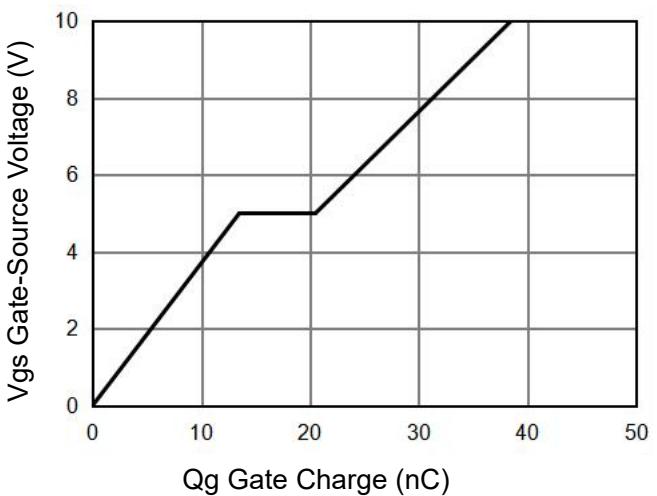
**Figure 1 Output Characteristics**



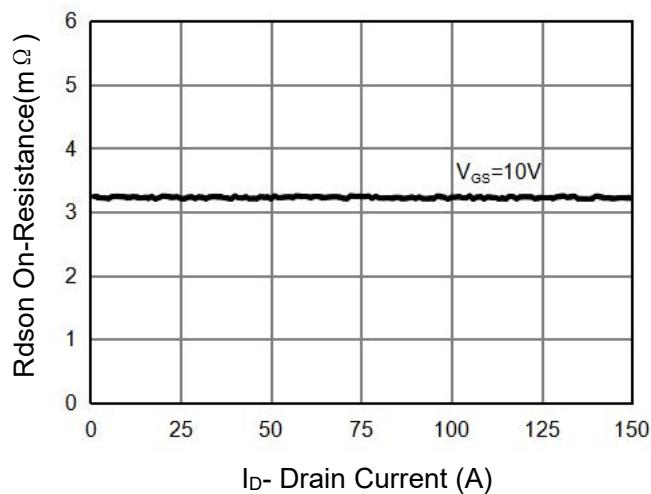
**Figure 4 Rdson-JunctionTemperature**



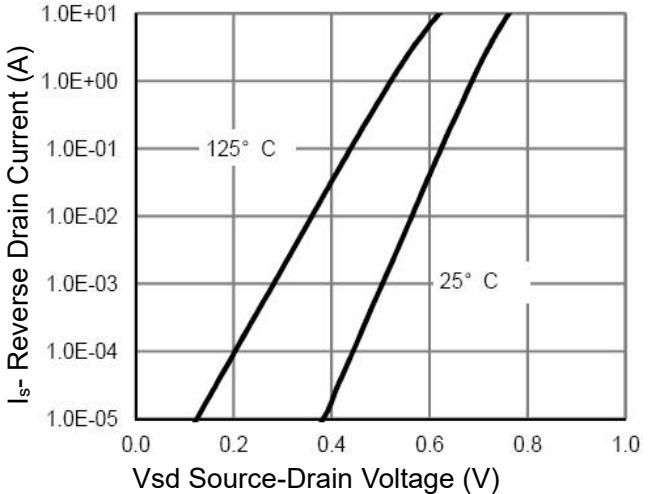
**Figure 2 Transfer Characteristics**



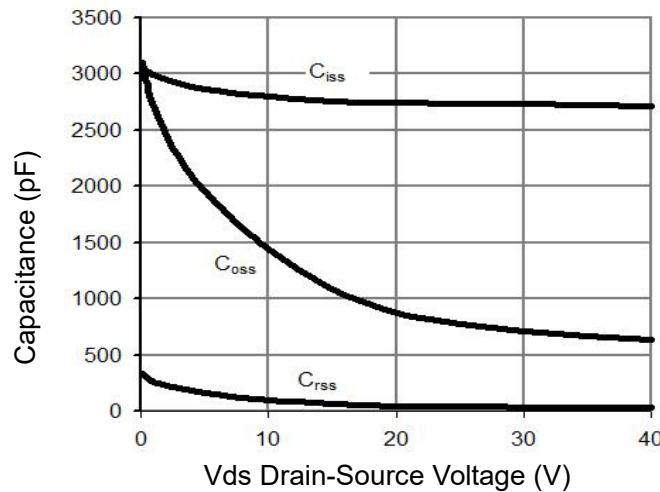
**Figure 5 Gate Charge**



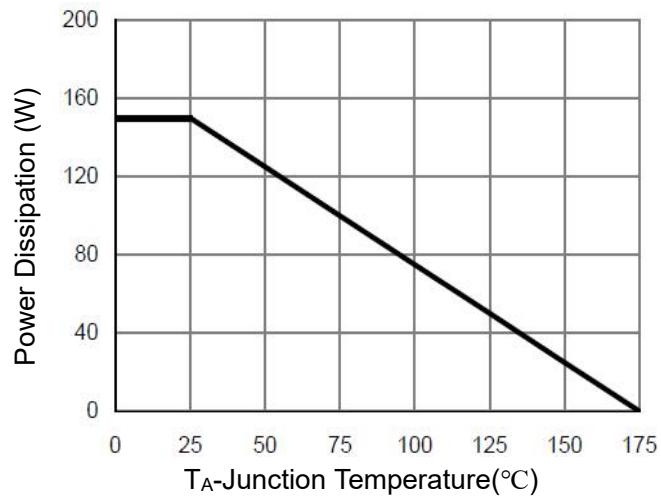
**Figure 3 Rdson- Drain Current**



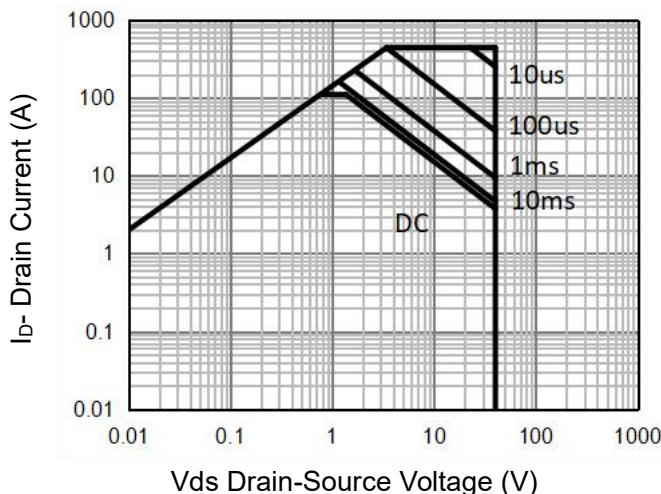
**Figure 6 Source- Drain Diode Forward**



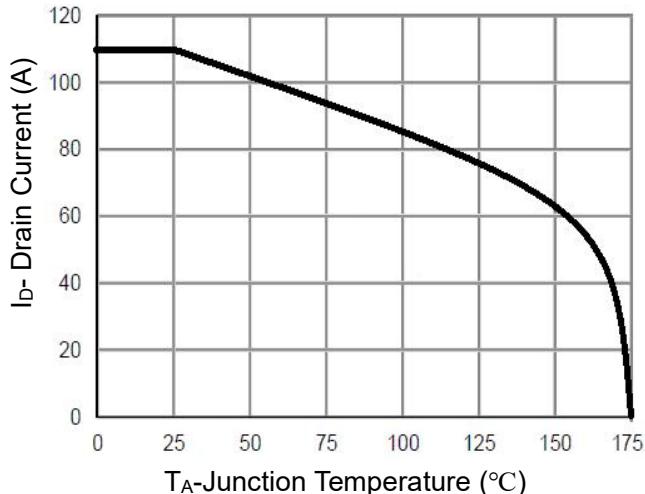
**Figure 7 Capacitance vs Vds**



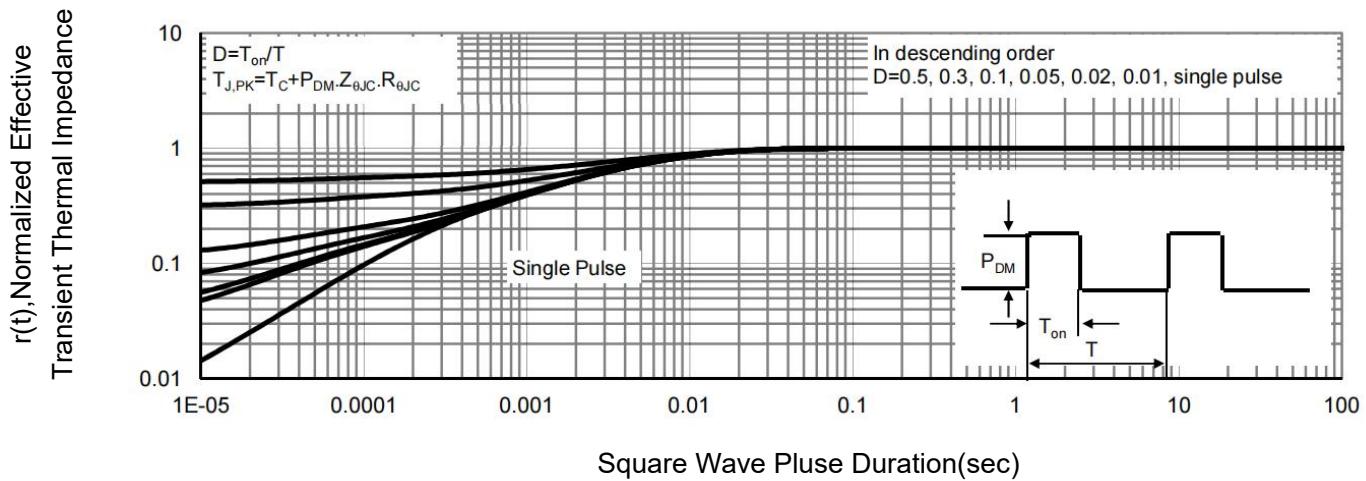
**Figure 9 Power De-rating**



**Figure 8 Safe Operation Area** (Note 3)

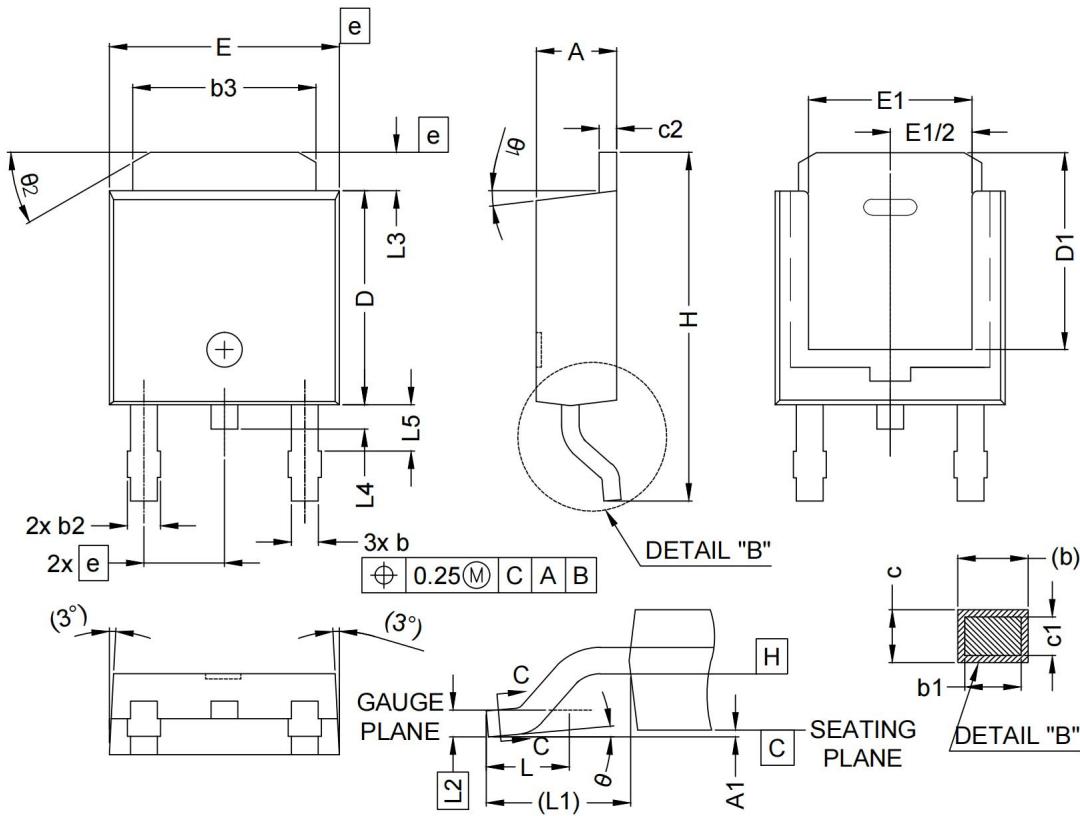


**Figure 10 Current De-rating**



**Figure 11 Normalized Maximum Transient Thermal Impedance**

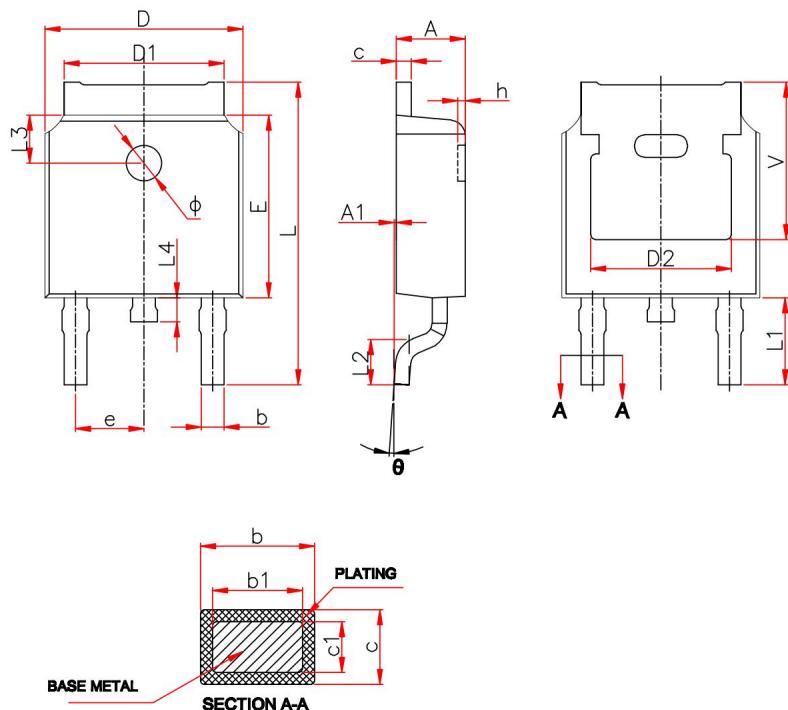
## TO-252-2L(B) Package Information



SYMBOL	MIN.	MAX.	SYMBOL	MIN.	MAX.	SYMBOL	MIN.	MAX.
A	2.18	2.39	E	6.35	6.73	θ1	0°	15°
A1	-	0.13	E1	4.32	-	θ2	25°	35°
b	0.65	0.89	e	2.29	BSC			
b1	0.64	0.79	H	9.94	10.34			
b2	0.76	1.13	L	1.50	1.78			
b3	4.95	5.46	L1	2.74	REF			
c	0.46	0.61	L2	0.51	BSC			
c1	0.41	0.56	L3	0.89	1.27			
c2	0.46	0.60	L4	-	1.02			
D	5.97	6.22	L5	1.14	1.49			
D1	5.21	-	θ	0°	10°			

NOTE ;  
 1.0 DIMENSIONING & TOLERANCEING CONFIRM TO ASME Y14.5M-1994.  
 2.0 ALL DIMENSIONS ARE IN MILLIMETERS. ANGLES ARE IN DEGREES.  
 3.0 HEAT SINK SIDE FLASH IS MAX. 0.8mm.  
 4.0 RADIUS ON TERMINAL IS OPTIONAL.

## TO-252-2L(E) Package Information



Symbol	Millimeters	
	Min.	Max.
A	2.20	2.40
A1	0.00	0.13
b	0.66	0.86
b1	0.73	0.79
c	0.46	0.58
c1	0.50	0.52
D	6.50	6.70
D1	5.10	5.46
D2	4.83 REF.	
E	6.00	6.20
e	2.19	2.39
L	9.80	10.40
L1	2.90 REF.	
L2	1.40	1.70
L3	1.60 REF.	
L4	0.60	1.00
Φ	1.10	1.30
θ	0°	8°

### Attention

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